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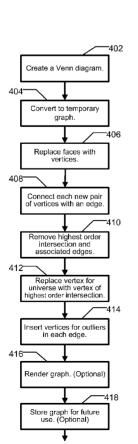
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[Continued on next page]

(54) Title: APPARATUS AND METHOD FOR VISUALIZING THE RELATIONSHIP BETWEEN A PLURALITY OF SETS



A computer readable storage medium includes executable instructions to associate two or more data sets with two or more vertices in a Venn graph. An intersection of the two or more data sets is associated with a vertex in the Venn graph. A plurality of outliers is associated between the two or more data sets and the intersection of the two or more data sets with a plurality of vertices disposed between the two or more vertices and the vertex in the Venn graph.

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A. CLASSIFICATION OF SUBJECT MATTER IPC(8) - G06F 3/00 (2008.01) USPC - 715/762 According to International Patent Classification (IPC) or to both national classification and IPC			
B. FIELDS SEARCHED Minimum documentation searched (classification system followed by classification symbols)			
USPC: 715/762			
Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched USPC: 715/211,215,762;707/E17.082 (text search - see terms below)			
Electronic data base consulted during the international search (name of data base and, where practicable, search terms used) PubWEST(USPT,PGPB,EPAB,JPAB); DialogPRO(Engineering); Google Scholar Search Terms Used: Venn graph, dual graph, Venn diagram, vertex/edge, intersection, isomorphism, graphical user interface (GUI), enterprise information management (EIM)			
C. DOCUMENTS CONSIDERED TO BE RELEVANT			
Category*	Citation of document, with indication, where appropriate, of the relevant passages		Relevant to claim No.
Y	US 6,326,962 B1 (SZABO) 04 December 2001 (04.12.2001) (Fig. 6-7, col 4, ln 6-14, col 14, ln 34-67, col 15, ln 61-col 16, ln 6, col 19, ln 51-58, col 20, ln 62-col 21, ln 25)		1-18
Y	US 2003/0182310 A1 (CHARNOCK et al.) 25 September 2003 (25.09.2003) (para [0106], para [0120], para [0302], para [0559], para [0561])		1-18
Y	BETTE et al, "Venn Diagrams with Few Vertices", The Electronic Journal of Combinatorics 1998, volume 5(1), #R44, p. 1-21 [retrieved on 2008-02-03]. Retrieved from the Internet: <url:http: ejc="" journals="" pdf="" v5i1r44.pdf="" volume_5="" www.emis.de=""></url:http:>		1-18
Α	US 2005/0239111 A1 (VAN RHEE et al.) 27 October 2005 (27.10.2005)		1-18
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means being obvious to a person skilled in the art "P" document published prior to the international filing date but later than "&" document member of the same patent family the priority date claimed			
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